

Notice of References Cited

Application/Control No.

10/595,523

Applicant(s)/Patent Under

Reexamination

NAKAYAMA ET AL.

Examiner

JAE LEE

Art Unit

2823

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0106217 A1	06-2004	Higgs, Victor	438/005
*	B	US-2004/0213309 A9	10-2004	Amano et al.	372/045
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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